

<b>Notice of References Cited</b>	Application/Control No. 10/751,208	Applicant(s)/Patent Under Reexamination HUAJIE CHEN	
	Examiner Thanh Y. Tran	Art Unit 2822	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0033639	02-2004	Chinn et al.	438/59
*	B	US-2002/0124867	09-2002	Kim et al.	134/1.2
	C	US-			
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	K	US-			
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	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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